

Search Notes**Application/Control No.**

10/564,444

Examiner

Tejash D. Patel

**Applicant(s)/Patent under
Reexamination**

MEGED, DAVID

Art Unit

3765

SEARCHED

Class	Subclass	Date	Examiner
Updated	Search from 1/16/08	10/24/2008	TP

INTERFERENCE SEARCHED

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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR